

C0603C332J5HACTU

Aliases (C0603C332J5HAC7867) SMD Comm X8R HT150C, Ceramic, 3,300 pF, 5%, 50 VDC, X8R, SMD, MLCC, High Temperature, Ultra-Stable, 0603, 0.5 mm



	General Information		
	Series	SMD Comm X8R HT150C	
	Style	SMD Chip	
	Description	SMD, MLCC, High Temperature, Ultra-Stable	
	Features	High Temperature, Ultra-Stable	
	RoHS	Yes	
	Termination	Tin	
	Marking	No	
	AEC-Q200	No	
	Typical Component Weight	4.8 mg	
	Shelf Life	78 Weeks	
	MSL	1	

		Specifications
	0603	Capacitance
	1.6mm +/-0.15mm	Measurement Condition
	0.8mm +/-0.15mm	Tolerance
	0.8mm +/-0.07mm	Voltage DC
	0.5mm MIN	Dielectric Withstanding Voltage
	0.35mm +/-0.15mm	Temperature Range
		Temp. Coefficient
ifications	T&R, 180mm, Paper Tape	Capacitance Change with Reference to +25°C and 0 VDC

Packaging Specifica	tione

Dimensions Chip Size

L W T S B

PackagingT&R, 180mPackaging Quantity4000

Specifications	
Capacitance	3,300 pF
Measurement Condition	1 kHz 1.0Vrms
Tolerance	5%
Voltage DC	50 VDC
Dielectric Withstanding Voltage	125 VDC
Temperature Range	-55/+150°C
Temp. Coefficient	X8R
Capacitance Change with Reference to +25°C and 0 VDC Applied (TCC)	15%, 1kHz 1.0Vrms
Dissipation Factor	2.5%1kHz1.0Vrms
Aging Rate	0% Loss/Decade Hour: Referee Time is 1000 Hours
Insulation Resistance	100 GOhms

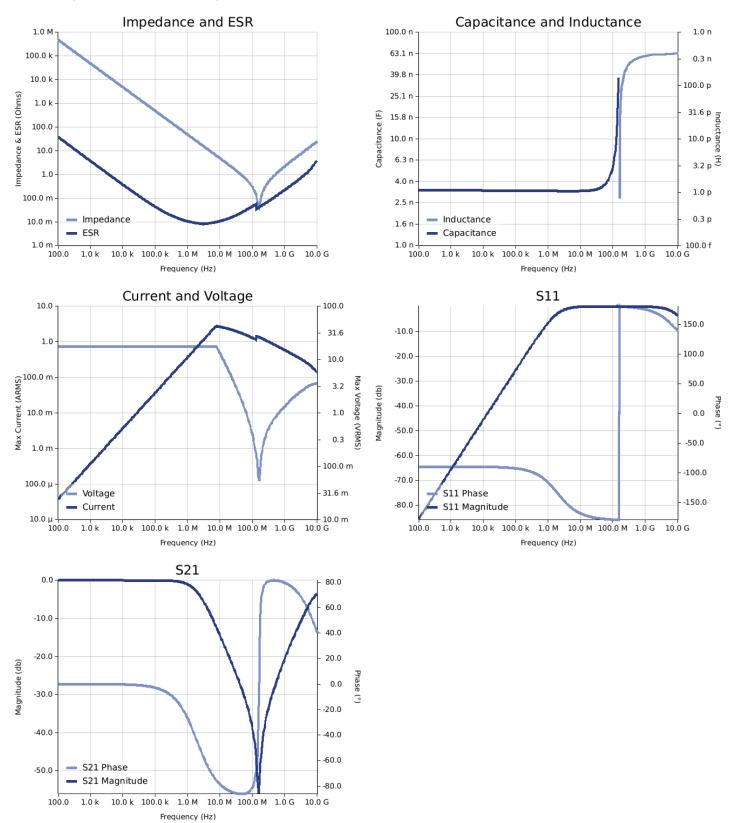
Statements of suitability for certain applications are based on our knowledge of typical operating conditions for such applications, but are not intended to constitute - and we specifically disclaim - any warranty concerning suitability for a specific customer application or use. This Information is intended for use only by customers who have the requisite experience and capability to determine the correct products for their application. Any technical advice inferred from this Information or otherwise provided by us with reference to the use of our products is given gratis, and we assume no obligation or liability for the advice given or results obtained.



CO603C332J5HACTU Aliases (C0603C332J5HAC7867) SMD Comm X8R HT150C, Ceramic, 3,300 pF, 5%, 50 VDC, X8R, SMD, MLCC, High Temperature, Ultra-Stable, 0603, 0.5 mm

Simulations

For the complete simulation environment please visit K-SIM.





C0603C332J5HACTU

Aliases (C0603C332J5HAC7867) SMD Comm X8R HT150C, Ceramic, 3,300 pF, 5%, 50 VDC, X8R, SMD, MLCC, High Temperature, Ultra-Stable, 0603, 0.5 mm

These are simulations.

This is not a specification!

The responses shown represent the typical response for each part type. Specific responses may vary, depending on manufacturing variation affects of all parameters involved, including the specified tolerances applied to capacitance and unspecified variations of ESR, ESL, and leakage resistance.

The responses shown do not represent a specified or implied maximum capability of the device for all applications.

- The ESR used for ripple "Ripple Current/Voltage vs. Frequency" plots is the ESR at ambient temperature.

- The ESR is the "Temperature Rise vs. Ripple Current," voltage vs. Frequency plots is the ESR at ambient temperature. The ESR in the "Temperature Rise vs. Ripple Current," plots is adjusted to each incremental temperature rise before the power and ripple current is calculated. The effects shown herein are based on measured data from a multiple part sample of the parts in question. Ripple capability of this device will be factored by thermal resistance (Rth) created by circuit traces (addi affects of all parameters involved, including the specified tolerances applied to capacitance and unspecified variations of ESR, ESL, and leakage resistance. The peak voltages generated in the "Temperature Rise vs. Combined Ripple Currents" plot are calculated for each frequency and are not combined with voltages
- generated at any other harmonics. Please consult with the catalog or field applications engineer for maximum capability of the device in specific applications.

All product information and data (collectively, the "Information") are subject to change without notice.

KEMET K-SIM is designed to simulate behavior of components with respect to frequency, ambient temperature, and DC bias levels. The responses shown represent the typical response for each part type. Specific responses may vary, depending on manufacturing variation effects of all parameters involved, including the specified tolerances applied to capacitance and unspecified variations of ESR, ESL, and leakage resistance.

All Information given herein is believed to be accurate and reliable, but is presented without guarantee, warranty, or responsibility of any kind, expressed or implied. Statements of suitability for certain applications are based on our knowledge of typical operating conditions for such applications, but are not intended to constitute – and we specifically disclaim – any warranty concerning suitability for a specific customer application or use. This Information is intended for use only by customers who have the requisite experience and capability to determine the correct products for their application. Any technical advice inferred from this Information or otherwise provided by us with reference to the use of our products is given gratis, and we assume no obligation or liability for the advice given or results obtained.

If you have any questions please contact K-SIM.